

Application/Control No.	Applicant(s)/Patent under Reexamination WU, JEN-SHI	
10/708,706		
Examiner	Art Unit	
Jean W. Désir	2622	

SEARCHED					
Class	Subclass	Date	Examiner		
348	663	8/22/18	6		
	665				
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
345	664	-8/29	10/0		
	667		Ψ		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EH-ST	9/28/	60		
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